## Notice of References Cited

	Application/Control No. 10/709,943	Applicant(s)/Patent Under Reexamination HSIEH ET AL.			
	Examiner	Art Unit			
ĺ	Eric Rush	2624	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0276471	12-2005	Shin et al.	382/162
*	В	US-7,177,462	02-2007	Hirota et al.	382/162
*	С	US-6,118,552	09-2000	Suzuki et al.	382/166
*	D	US-2005/0163374	07-2005	Ferman et al.	382/176
	E	US-			
	F	US-		·	
	G	US-			· · · · · ·
	Н	US-			
	1	US-			
	J	US-			
	K	US-		·	
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

TOTAL OF TATELLY BOOGMETERS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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